





## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of	)
Shunpei YAMAZAKI et al.	)
Serial No. 09/894,125	)
Filed: June 29, 2001	)
For: CRYSTALLINE SEMICONDUCTOR	R)
THIN FILM, METHOD OF FABRICATING	)
THE SAME, SEMICONDUCTOR DEVICE	(,)
AND METHOD OF FABRICATING THE	)
SAME	)

Art Unit: 2823

Examiner: B. Kebede

## **CERTIFICATE OF MAILING**

I hereby certify that this correspondence is being deposited with The United States Postal Service with sufficient postage as First Class Mart in an envelope addressed to: Commissioner for Patents, Washington, D.C. 20231, on

Ava M. Dixon

## **AMENDMENT**

Honorable Commissioner of Patents Washington, D.C. 20231

Sir:

In response to the Office Action dated April 24, 2002 please amend the aboveidentified application as follows:

## IN THE CLAIMS:

Please amend claims 1-6, 10-12 and 19-30 as follows:

(Amended) A method of manufacturing a semiconductor device comprising the steps of

forming a semiconductor film comprising silicon over a substrate;

irradiating said semiconductor film with laser light in air for crystallizing said semiconductor film;

removing an oxide film formed on a surface of the semiconductor film by etching after the irradiation of the laser light; and

leveling the surface of the semiconductor film by heating after removing said oxide film.

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